Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/617,113	CHOWN, DAVID		
Examiner	Art Unit		
Leslie Pascal	2613		

SEARCHED				
Class	Subclass	Date	Examiner	
398	135-139	11/7/2006	LP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see search notes	11/6/200)7 _P	